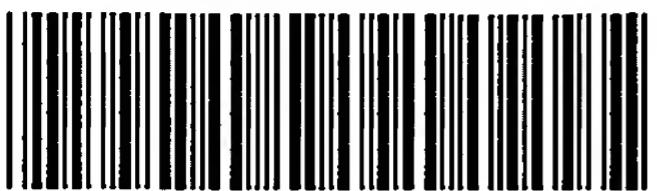


Search Notes



Application/Control No.

10/602.629

Examiner

John D. Lee

**Applicant(s)/Patent under
Reexamination**

WATANABE, SHIGEKI

Art Unit

2874

SEARCHED

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

INTERFERENCE SEARCHED

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
359	326-332	7/27/2005	JDL
359	107,108	7/27/2005	JDL